Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/002,318	MAGEE, DAVID PATRICK	
Examiner	Art Unit	
Krista M. Flanagan	2631	

SEARCHED					
Class	Subclass	Date	Examiner		
			•		
1					
	*				
	-				
		0			

INTERFERENCE SEARCHED				
Class	Subclass	Dạte	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (Bocure)	1/24/2005	KMF		
Inventorship EAST (Bocure)	1/28/2005	KMF		
375/224, 226, 344, 345, 371, and 375 See Search Notes	1/24/2005	KMF		
Updated Search - See Search Notes	7/18/2005	kmf		
IEEE Xplore - See search notes	7/18/2005	KMF		
Updated Search - See Search Notes	7/27/2005	KMF		
Updated Search - See Search Notes	7/29/2005	KMF		
		-		